

FORM PTO 1449 (Modified)

LIST OF PATENTS AND
PUBLICATIONS FOR
APPLICANT'S INFORMATION
DISCLOSURE STATEMENTPage 1 of 2

ATTY. DOCKET NO. EI-2-04-002

SERIAL NO.

N/A

APPLICANT Lauffer et al

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GROUP

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U. S. PATENT DOCUMENTS

EXAMINER INITIALS		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILIN G
HN	AA	5,031,073	07/91	Chang			
	AB	5,196,230	03/93	Okonogi et al			
	AC	5,649,160	07/97	Corry et al			
	AD	5,684,340	11/97	Soler et al			
	AE	6,020,614	02/00	Worley			
	AF	6,040,524	03/00	Kobayashi et al			
	AG	6,429,752 B1	08/02	Harju et al			
	AH	6,429,757 B1	08/02	Karlsson et al			
	AI	6,522,214 B1	02/03	Harju et al			
	AJ	6,529,229 B2	03/03	Nagumo			
	AK	2002/0100613 A1	08/02	Anstrom et al			
	AL	2002/0108780 A1	08/02	Blackwell et al			

FOREIGN PATENT DOCUMENTS

EXAMINER INITIALS		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
	AM						
	AN						
	AO						
	AP						

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<i>HA</i>	AA	2002/0148637 A1	10/02	Anstrom et al			
<i>HA</i>	AB	2004/0009666 A1	01/04	Ishizuki et al			
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